INTERNATIONAL STANDARD

ISO/IEC 10373-2

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Identification cards — Test methods — Part 2: Cards with magnetic stripes

Cartes d'identification — Méthodes d'essai — Partie 2: Cartes à bandeaux magnétiques



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Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in jields of mutual interest. Other international organizations, governmental and nongovernmental, in liaison with ISO and IEC, also take part in the work. In the field of information technology, ISO and IEC have established a pint technical committee, ISO/IEC JTC 1.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of the joint technical committee is to prepare International Standards. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO and IEC shall not be held responsible for identifying any or all such patent rights.

ISO/IEC 10373-2 was prepared by Joint Technical Committee ISO/IEC JTC 1, Information technology, Subcommittee SC 17, Cards and personal identification.

This second edition cancels and replaces the first edition (ISO/IEC 10373-2:1998), which has been technically revised.

ISO/IEC 10373 consists of the following parts, under the general title *Identification cards* — *Test methods*:

- Part 1: General characteristics
- Part 2: Cards with magnetic stripes
- Part 3: Integrated circuit(s) cards with contacts and related inter
- Part 5: Optical memory cards
- Part 6: Proximity cards
- Part 7: Vicinity cards

Identification cards — Test methods —

Part 2:

Cards with magnetic stripes

1 Scope

ISO/IEC 10373 defines test methods for characteristics of identification cards according to the definition given in ISO/IEC 7810. Each test method is cross-referenced to one or more base standards, which may be ISO/IEC 7810 or one or more of the supplementary standards that define the information storage technologies employed in identification card applications.

This part of ISO/IEC 10373 defines test methods which are specific to magnetic stripe technology.

NOTE 1 - Criteria for acceptability do not form part of this part of ISO/IEC 10373 but will be found in the International Standards mentioned above.

NOTE 2 - Test methods described in this part of 150/JEC 10373 are intended to be performed separately. A given card is not required to pass through all the tests sequentially

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated efferences, the latest edition of the referenced document (including any amendments) applies.

ISO 1302, Geometrical Product Specficiations (GPS) — Indication of surface texture in technical product documentation

ISO 2409:1992, Paints and varnishes — Cross-cut test

ISO 3274, Geometrical Product Specifications (GPS) — Surface texture: Profile method — Nominal characteristics of contact (stylus) instruments

ISO 4288, Geometrical Product Specifications (GPS) — Surface texture: Profile method — Rules and procedures for the assessment of surface texture

ISO/IEC 7811-2, Identification cards — Recording technique — Part 2: Magnetic stripe — Low coercivity

ISO/IEC 7811-6, Identification cards — Recording technique — Part 6: Magnetic stripe — High coercivity

ISO/IEC 7811-7, Identification cards — Recording technique — Part 7: Magnetic stripe — High coercivity, high density

IEC 454-2, Specification for pressure-sensitive adhesive tapes for electrical purposes — Part 2: Methods of test